

Application/Control No.	Applicant(s)/Patent unde Reexamination	r	
10/775,324	NAWASHIRO ET AL.	NAWASHIRO ET AL.	
Examiner	Art Unit		
Fazli Erdem	2826		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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